NOTES:

SUBSTRATE MATERIAL:
 FUSED SILICA

- 2. SURFACE S2 TO BE PARALLEL TO SURFACE S1 < 3 ARCSEC
- 3. COATING (APPLY ACROSS COATING APERTURE)

\$1: ULTRAFAST LASER
Rs >99.75% @ 500 - 530nm
Rp >99.5% @ 500 - 530nm

S2: NONE

DAMAGE THRESHOLD, PULSED:

0.17 J/cm² @ 515nm, 178fs, 1 pulse (typical)

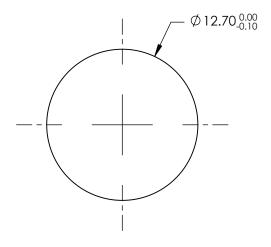
0.15 J/cm² @ 515nm, 178fs, 10kHz, 1000 pulses (typical)

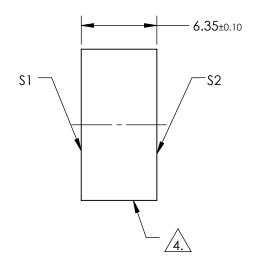
GROUP DELAY DISPERSION:

S-pol: 0 ±20fs² @ 500 - 530nm P-pol: 0 ±20fs² @ 500 - 530nm



5. RoHS: COMPLIANT





FOR INFORMATION ONLY: DO NOT MANUFACTURE PARTS TO THIS DRAWING

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

	\$1	\$2 PLANO	
SHAPE	PLANO		
SURFACE FLATNESS	λ/8	N/A	
SURFACE QUALITY	20-10	COMMERCIAL POLISH	
CLEAR APERTURE (%)	11.43	N/A	
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	

		Edmund Optic	S®
THIRD ANGLE PROJECTION	TITLE	500 - 530nm, 12.7mm Dia., Ultrafast M	irror
ALL DIMS IN mm	DWG NO	17551	SHEET 1 OF 1

